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Standard Practice for Exposing a Membrane Switch to Variation in Atmospheric Pressure¹

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1. Scope

1.1 This practice covers a procedure for exposing a membrane switch to variations in atmospheric pressure. It can be used to determine the effects of pressure variations on chemical and mechanical properties and functional characteristics of the switch.

2. Terminology

2.1 Definitions:

2.1.1 *circuit resistance*—electrical resistance as measured between two test points whose internal contacts, when held closed, complete a circuit.

2.1.2 *contact closure*—the event at which a specified resistance is achieved on a membrane switch.

2.1.3 *membrane switch*—a momentary switching device in which at least one contact is on, or made of, a flexible substrate.

2.1.4 *specified resistance*—the maximum allowable circuit resistance as measured between two test points whose internal contacts, when held closed, complete a circuit.

2.1.5 *test points*—two preselected conductive points in a circuit loop, possibly including a switch.

3. Significance and Use

3.1 Erratic operation or malfunction of a membrane switch resulting from changes in the specified switch characteristics,

3.2 Rupture, implosion or explosion of seals due to pressure variations,

3.3 Change in physical or chemical properties due to pressure differentiations, and

3.4 Delaminations of a membrane switch may occur due to pressure variations.

4. Interferences

4.1 Time duration before, during and after pressure cycling,

4.2 Temperature,

4.3 Humidity,

4.4 Mounting Method (if applicable).

5. Apparatus

5.1 *Pressure Chamber*, a chamber or cabinet capable of maintaining a specified pressure. If procedurally required, the apparatus shall be capable of providing pressure variation at a specified rate.

5.2 *Monitoring Device*, suitable to detect contact closure (that is, ohm meter, etc.).

6. Conditioning

6.1 Condition all specimens for 72 h at ambient laboratory conditions immediately prior to exposure, or prior to pressure cycling. This is to enable the specimens to stabilize.

7. Procedure

7.1 Pretest Setup:

7.1.1 Measure or observe the desired characteristics of the switch so that comparable measurements and observations can be made during or after the test.

7.1.1.1 Document the setup, test equipment, and mounting procedure (if applicable) used to measure the characteristics.

7.1.2 Connect predetermined switch terminations to contact closure measuring device.

7.2 In-Process Test:

7.2.1 Place specimens in the chamber at ambient conditions, record time and date, and initiate contact closure monitoring device.

7.2.2 Adjust the ramp rate to decrease air pressure at 2000 ft/min unless otherwise specified.

7.2.3 Set pressure as specified.

7.2.4 Maintain the chamber pressure for the specified time interval.

7.2.5 Return chamber pressure to the initial ambient conditions at the specified rate.

7.2.6 Remove specimens and record time and date.

¹ This test method is under the jurisdiction of ASTM Committee F01 on Electronics and is the direct responsibility of Subcommittee F01.18 on Membrane Switches.

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7.3 Post Test:

7.3.1 Measure and observe the characteristics of the switch as in 7.1.1. Record time and date for each characteristic measured.

8. Precision and Bias

8.1 The precision and bias of this test are under investigation.

9. Keywords

9.1 contact closure; delamination; membrane switch

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